Searcn Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/705,883	ISHIKAWA ET AL.	
Examiner	Art Unit	
Philip H. Leung	3742	

SEARCHED			
Class	Subclass	Date	Examiner
219	698-702 704-705 762, 518	11/9/2005	P.L.
34	259, 264		
264	489-490		
425	174-174.4		
-			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

(INCLUDING SEA	NOTES)
		DATE	EXMR
Inventorship checked EAST searched	1	1/9/2005	P.L.
	,		